

ZXMC3F31DN8 **30V SO8 Complementary dual enhancement mode** **MOSFET**

Summary

Device	$V_{(BR)DSS}$ (V)	Q_G (nC)	$R_{DS(on)}$ (Ω)	I_D (A)
Q1	30	12.9	0.024 @ $V_{GS} = 10V$	7.3
			0.039 @ $V_{GS} = 4.5V$	5.7
Q2	-30	12.7	0.045 @ $V_{GS} = -10V$	5.3
			0.080 @ $V_{GS} = -4.5V$	4



Description

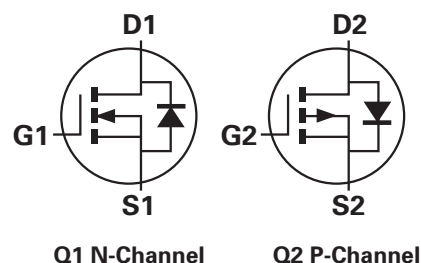
This new generation Trench MOSFET from Zetex has been designed to minimize the on-state resistance ($R_{DS(on)}$) and yet maintain superior switching performance making it ideal for power management and battery charging functions.

Features

- Low on-resistance
- 4.5V gate drive capability
- Low profile SOIC package

Applications

- DC-DC Converters
- SMPS
- Load switching switches
- Motor control
- Backlighting

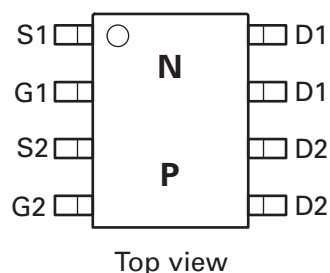


Ordering information

Device	Reel size (inches)	Tape width (mm)	Quantity per reel
ZXMC3F31DN8TA	7	12	500

Device marking

ZXMC
3F31



ZXMC3F31DN8

Absolute maximum ratings

Parameter	Symbol	N-channel Q1	P-channel Q2	Unit
Drain-Source voltage	V_{DSS}	30	-30	V
Gate-Source voltage	V_{GS}	± 20	± 20	V
Continuous Drain current @ $V_{GS} = 10V$; $T_A = 25^\circ C$ (b)(d) @ $V_{GS} = 10V$; $T_A = 70^\circ C$ (b)(d) @ $V_{GS} = 10V$; $T_A = 25^\circ C$ (a)(d) @ $V_{GS} = 10V$; $T_A = 25^\circ C$ (a)(e) @ $V_{GS} = 10V$; $T_L = 25^\circ C$ (f)(d)	I_D	7.3 5.9 5.7 6.8 7.8	5.3 4.3 4.1 4.9 5.7	A
Pulsed Drain current (c)	I_{DM}	33	23	A
Continuous Source current (Body diode) (b)(d)	I_S	3.5	3.2	A
Pulsed Source current (Body diode) (c)(d)	I_{SM}	33	23	A
Power dissipation at $T_A = 25^\circ C$ (a)(d) Linear derating factor	P_D	1.25 10		W mW/°C
Power dissipation at $T_A = 25^\circ C$ (a)(e) Linear derating factor	P_D	1.8 14		W mW/°C
Power dissipation at $T_A = 25^\circ C$ (b)(d) Linear derating factor	P_D	2.1 17		W mW/°C
Power dissipation at $T_L = 25^\circ C$ (f) (d) Linear derating factor	P_D	2.35 19		W mW/°C
Operating and storage temperature range	T_j, T_{stg}	-55 to 150		°C

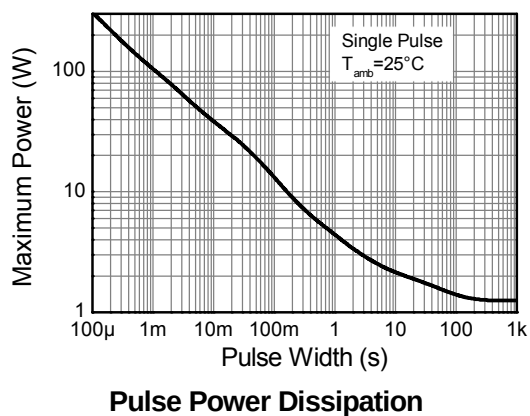
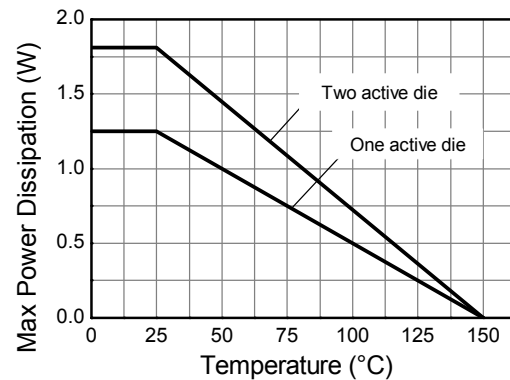
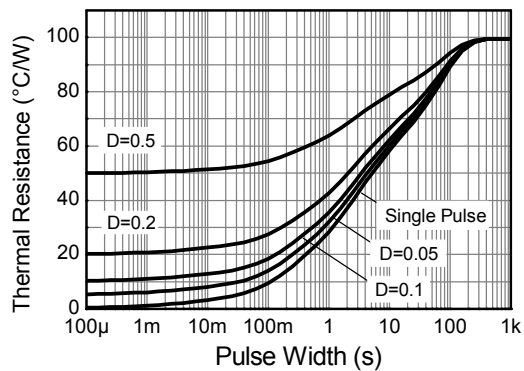
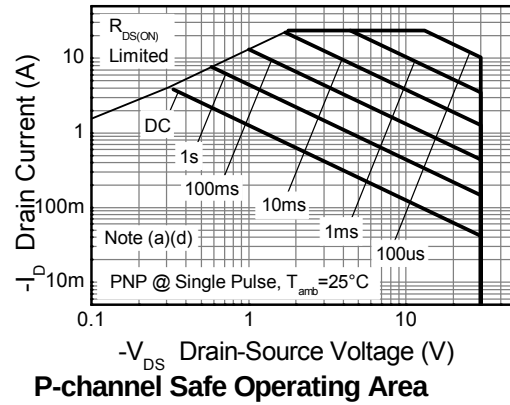
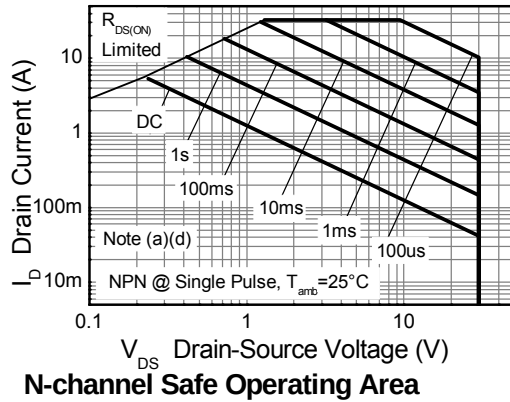
Thermal resistance

Parameter	Symbol	Value	Unit
Junction to ambient (a)(d)	$R_{\theta JA}$	100	°C/W
Junction to ambient (a)(e)	$R_{\theta JA}$	70	°C/W
Junction to ambient (b)(d)	$R_{\theta JA}$	60	°C/W
Junction to lead (f) (d)	$R_{\theta JL}$	53	°C/W

NOTES:

- (a) For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions.
- (b) Mounted on FR4 PCB measured at $t \leq 10$ sec.
- (c) Repetitive rating on 25mm x 25mm FR4 PCB, $D=0.02$, pulse width 300us – pulse width limited by maximum junction temperature.
- (d) For a device with one active die.
- (e) For a device with two active die running at equal power.
- (f) Thermal resistance from junction to solder-point (at the end of the drain lead).

Thermal characteristics



ZXMC3F31DN8

Q1 N-channel electrical characteristics (at $T_{amb} = 25^{\circ}\text{C}$ unless otherwise stated)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Static						
Drain-Source breakdown voltage	V _{(BR)DSS}	30			V	I _D = 250μA, V _{GS} =0V
Zero Gate voltage Drain current	I _{DSS}			0.5	μA	V _{DS} =30V, V _{GS} =0V
Gate-Body leakage	I _{GSS}			100	nA	V _{GS} =±20V, V _{DS} =0V
Gate-Source threshold voltage	V _{GS(th)}	1.0		3.0	V	I _D = 250μA, V _{DS} =V _{GS}
Static Drain-Source on-state resistance (*)	R _{DS(on)}			0.024 0.039	Ω	V _{GS} = 10V, I _D = 7.0A V _{GS} = 4.5, I _D = 6.0A
Forward Transconductance (*) (†)	g _{fs}		16.5		S	V _{DS} = 15V, I _D = 7.0A
Dynamic (†)						
Input capacitance	C _{iss}		608		pF	V _{DS} = 15V, V _{GS} =0V f=1MHz
Output capacitance	C _{oss}		132		pF	
Reverse transfer capacitance	C _{rss}		72		pF	
Switching (‡) (†)						
Turn-on-delay time	t _{d(on)}		2.9		ns	V _{DD} = 15V, V _{GS} =10V I _D = 1A R _G ≐ 6.0Ω,
Rise time	t _r		3.3		ns	
Turn-off delay time	t _{d(off)}		16		ns	
Fall time	t _f		8		ns	
Total Gate charge	Q _g		12.9		nC	V _{DS} = 15V, V _{GS} = 10V I _D = 7A
Gate-Source charge	Q _{gs}		2.5		nC	
Gate-Drain charge	Q _{gd}		2.52		nC	
Source-Drain diode						
Diode forward voltage (*)	V _{SD}		0.82	1.2	V	I _S = 1.7A,V _{GS} =0V
Reverse recovery time (‡)	t _{rr}		12		ns	I _S = 2.2A,di/dt=100A/μs
Reverse recovery charge(‡)	Q _{rr}		4.8		nC	

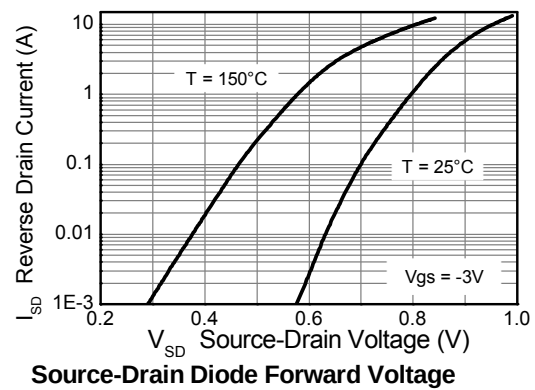
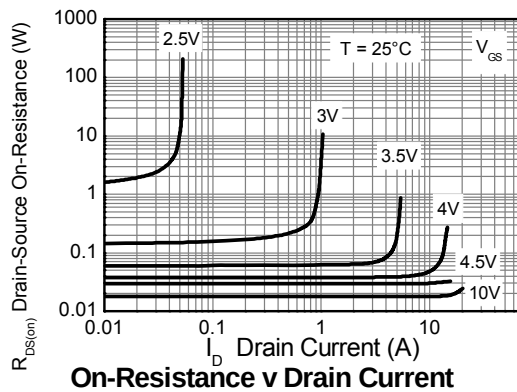
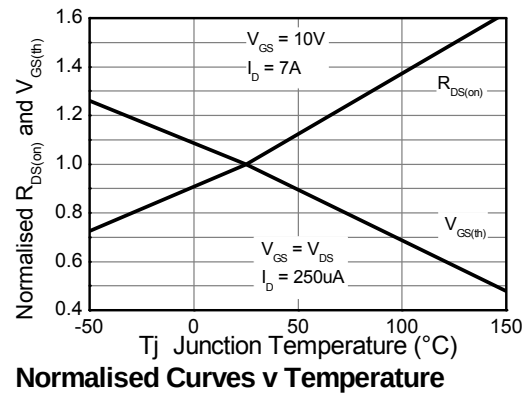
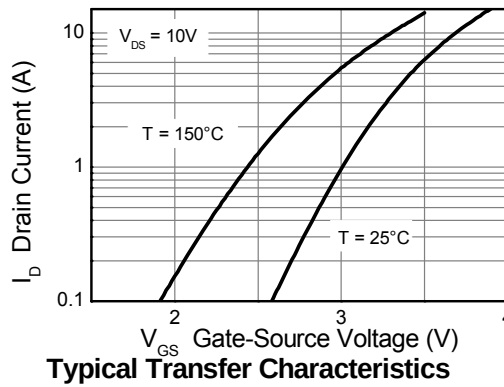
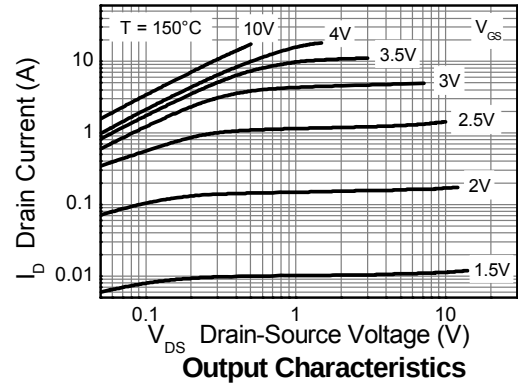
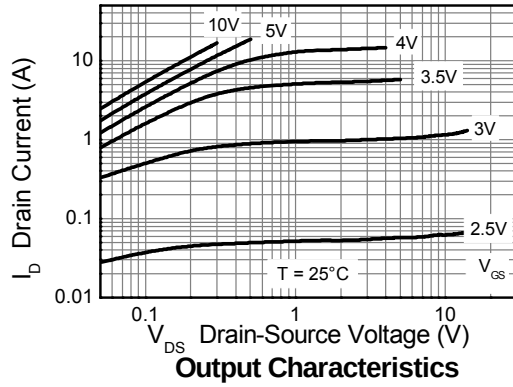
NOTES:

(*) Measured under pulsed conditions. Pulse width $\leq 300\mu\text{s}$; duty cycle $\leq 2\%$.

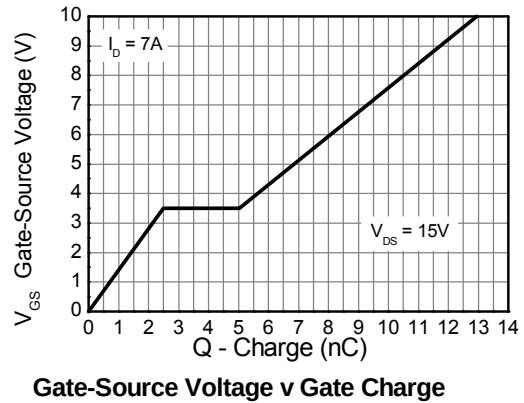
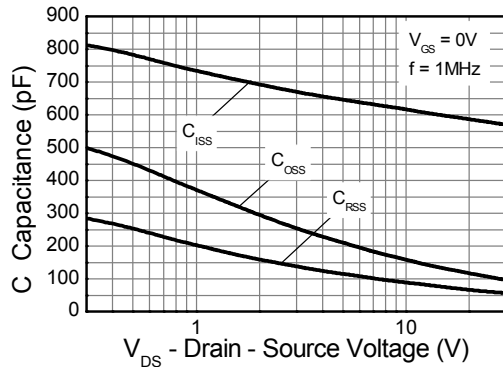
(†) Switching characteristics are independent of operating junction temperature.

(‡) For design aid only, not subject to production testing

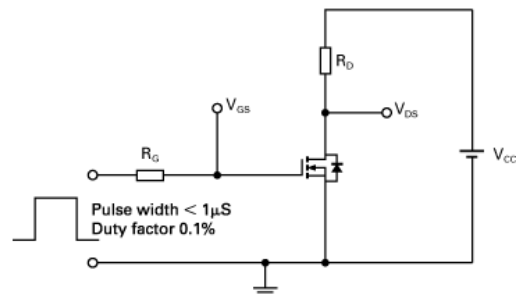
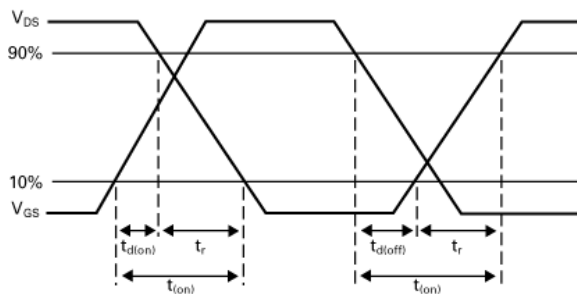
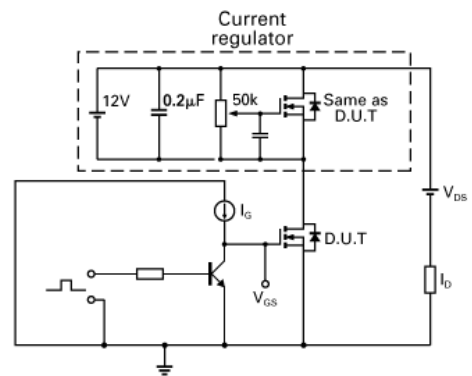
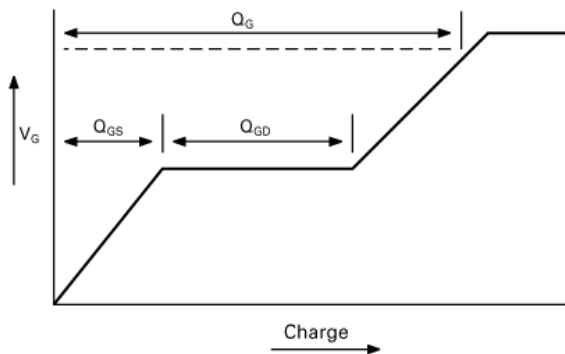
Q1 Typical characteristics



Q1 Typical characteristics –cntd.



Test circuits



ZXMC3F31DN8

Q2 P-channel electrical characteristics (at $T_{amb} = 25^{\circ}\text{C}$ unless otherwise stated)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Static						
Drain-Source breakdown voltage	V _{(BR)DSS}	-30			V	I _D = -250μA, V _{GS} =0V
Zero Gate voltage Drain current	I _{DSS}			-5.0	μA	V _{DS} =-30V, V _{GS} =0V
Gate-Body leakage	I _{GSS}			-100	nA	V _{GS} =±20V, V _{DS} =0V
Gate-Source threshold voltage	V _{GS(th)}	-1.0		-3.0	V	I _D = -250μA, V _{DS} =V _{GS}
Static Drain-Source on-state resistance ^(*)	R _{DS(on)}			0.045 0.080	Ω	V _{GS} = -10V, I _D = -5.0A V _{GS} = -4.5V, I _D = -4.0A
Forward Transconductance ^(*) (†)	g _{fs}		14		S	V _{DS} = -15V, I _D = -5.0A
Dynamic ^(†)						
Input capacitance	C _{iss}		670		pF	V _{DS} = -15V, V _{GS} =0V f=1MHz
Output capacitance	C _{oss}		126		pF	
Reverse transfer capacitance	C _{rss}		70		pF	
Switching ^(‡) (†)						
Turn-on-delay time	t _{d(on)}		1.9		ns	V _{DD} = -15V, V _{GS} =-10V I _D = -1A R _G ≐ 6.0Ω,
Rise time	t _r		3		ns	
Turn-off delay time	t _{d(off)}		30		ns	
Fall time	t _f		21		ns	
Total Gate charge	Q _g		12.7		nC	V _{DS} = -15V, V _{GS} = -10V I _D = -5A
Gate-Source charge	Q _{gs}		2		nC	
Gate-Drain charge	Q _{gd}		2.4		nC	
Source-Drain diode						
Diode forward voltage ^(*)	V _{SD}		-0.82	-1.2	V	I _S = -2A,V _{GS} =0V
Reverse recovery time ^(‡)	t _{rr}		16.5		ns	I _S = -2.1A,di/dt=100A/μs
Reverse recovery charge ^(‡)	Q _{rr}		11.5		nC	

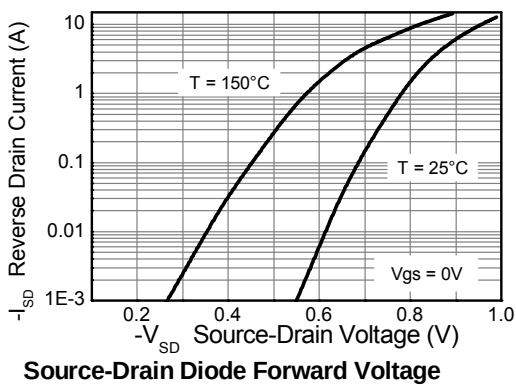
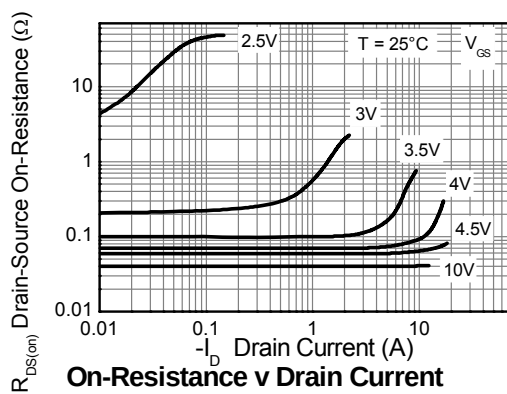
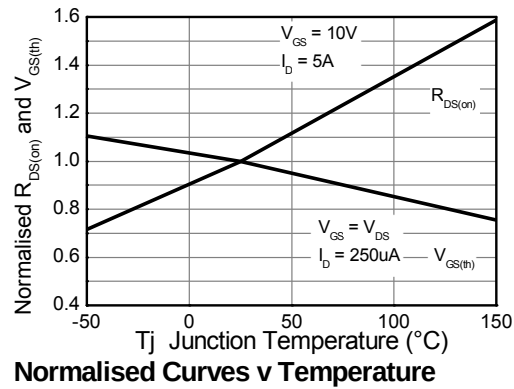
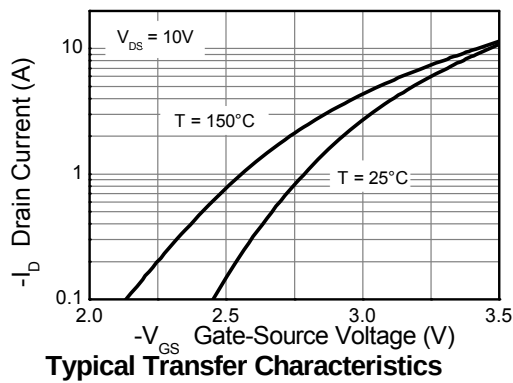
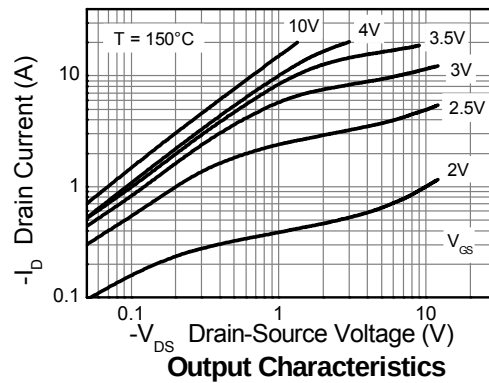
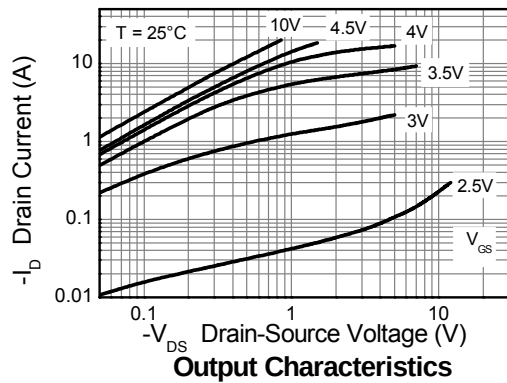
NOTES:

(*) Measured under pulsed conditions. Pulse width $\leq 300\mu\text{s}$; duty cycle $\leq 2\%$.

(†) Switching characteristics are independent of operating junction temperature.

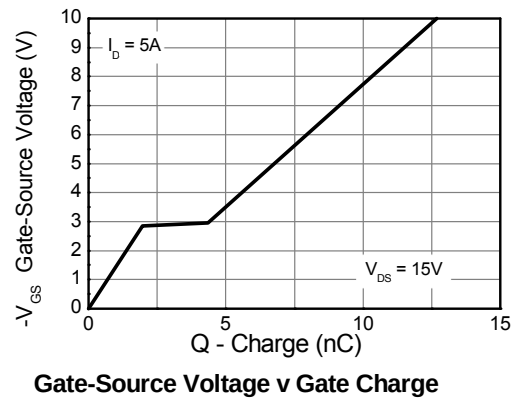
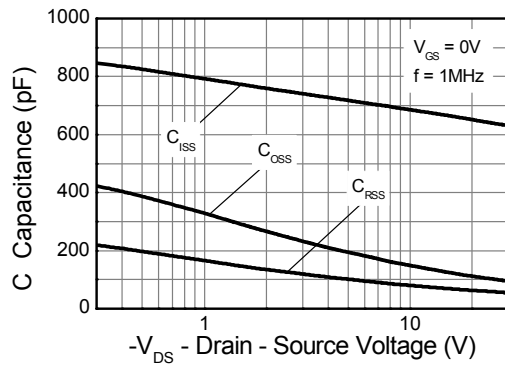
(‡) For design aid only, not subject to production testing

Typical characteristics

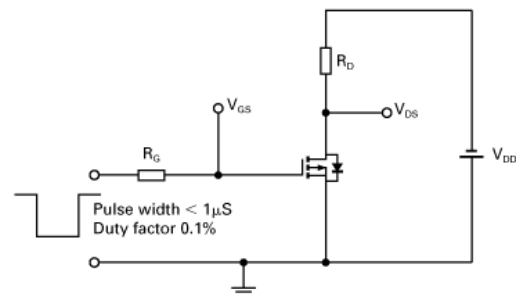
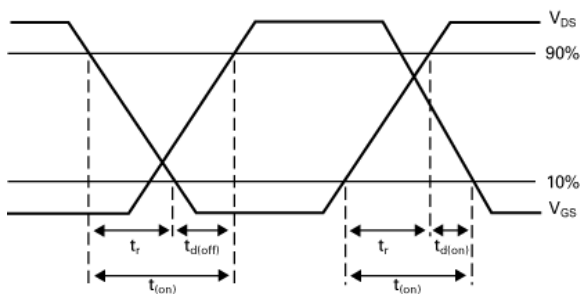
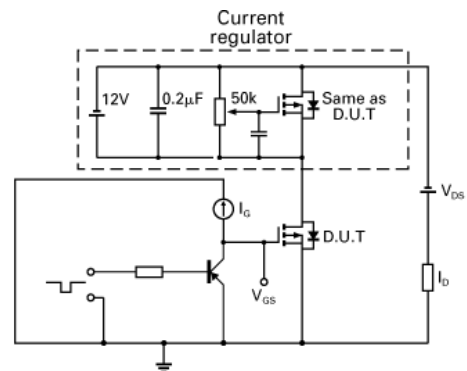
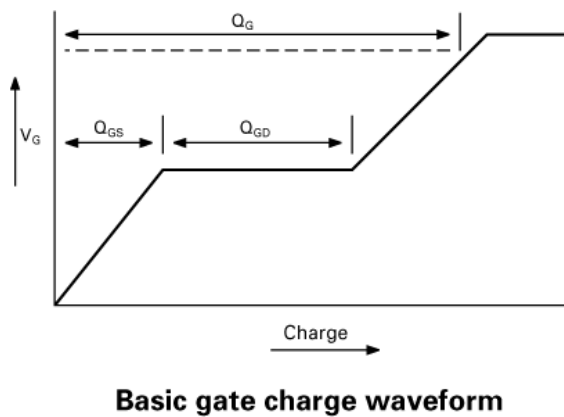


ZXMC3F31DN8

Typical characteristics

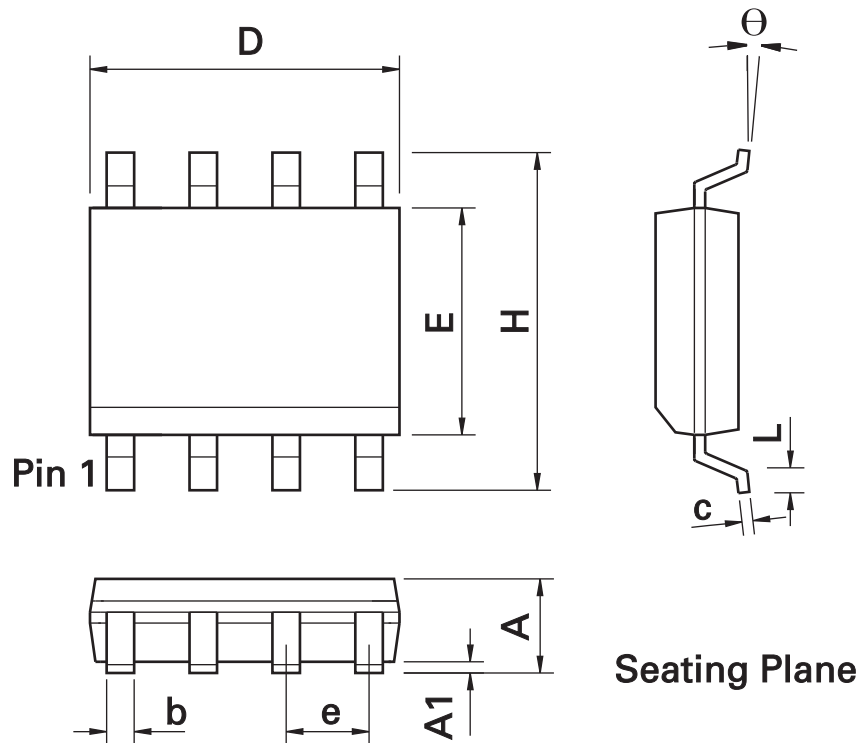


Test circuits



ZXMC3F31DN8

Package outline SO8



SO8 Package Information

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.053	0.069	1.35	1.75	e	0.050 BSC		1.27 BSC	
A1	0.004	0.010	0.10	0.25	b	0.013	0.020	0.33	0.51
D	0.189	0.197	4.80	5.00	c	0.008	0.010	0.19	0.25
H	0.228	0.244	5.80	6.20	U	0°	8°	0°	8°
E	0.150	0.157	3.80	4.00	h	0.010	0.020	0.25	0.50
L	0.016	0.050	0.40	1.27	-	-	-	-	-

Note: Controlling dimensions are in inches. Approximate dimensions are provided in millimeters

Definitions

Product change

Diodes Incorporated reserves the right to alter, without notice, specifications, design, price or conditions of supply of any product or service. Customers are solely responsible for obtaining the latest relevant information before placing orders.

Applications disclaimer

The circuits in this design/application note are offered as design ideas. It is the responsibility of the user to ensure that the circuit is fit for the user's application and meets with the user's requirements. No representation or warranty is given and no liability whatsoever is assumed by Diodes Inc. with respect to the accuracy or use of such information, or infringement of patents or other intellectual property rights arising from such use or otherwise. Diodes Inc. does not assume any legal responsibility or will not be held legally liable (whether in contract, tort (including negligence), breach of statutory duty, restriction or otherwise) for any damages, loss of profit, business, contract, opportunity or consequential loss in the use of these circuit applications, under any circumstances.

Life support

Diodes Zetex products are specifically not authorized for use as critical components in life support devices or systems without the express written approval of the Chief Executive Officer of Diodes Incorporated. As used herein:

- A. Life support devices or systems are devices or systems which:
1. are intended to implant into the body
- or
2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.
- B. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or to affect its safety or effectiveness.

Reproduction

The product specifications contained in this publication are issued to provide outline information only which (unless agreed by the company in writing) may not be used, applied or reproduced for any purpose or form part of any order or contract or be regarded as a representation relating to the products or services concerned.

Terms and Conditions

All products are sold subjects to Diodes Inc. terms and conditions of sale, and this disclaimer (save in the event of a conflict between the two when the terms of the contract shall prevail) according to region, supplied at the time of order acknowledgement.

For the latest information on technology, delivery terms and conditions and prices, please contact your nearest Diodes Zetex sales office.

Quality of product

Diodes Zetex Semiconductors Limited is an ISO 9001 and TS16949 certified semiconductor manufacturer.

To ensure quality of service and products we strongly advise the purchase of parts directly from Zetex Semiconductors or one of our regionally authorized distributors. For a complete listing of authorized distributors please visit: www.zetex.com or www.diodes.com

Diodes Incorporated does not warrant or accept any liability whatsoever in respect of any parts purchased through unauthorized sales channels.

ESD (Electrostatic discharge)

Semiconductor devices are susceptible to damage by ESD. Suitable precautions should be taken when handling and transporting devices. The possible damage to devices depends on the circumstances of the handling and transporting, and the nature of the device. The extent of damage can vary from immediate functional or parametric malfunction to degradation of function or performance in use over time. Devices suspected of being affected should be replaced.

Green compliance

Diodes Zetex Semiconductors is committed to environmental excellence in all aspects of its operations which includes meeting or exceeding regulatory requirements with respect to the use of hazardous substances. Numerous successful programs have been implemented to reduce the use of hazardous substances and/or emissions.

All Diodes Zetex components are compliant with the RoHS directive, and through this it is supporting its customers in their compliance with WEEE and ELV directives.

Product status key:

"Preview"	Future device intended for production at some point. Samples may be available
"Active"	Product status recommended for new designs
"Last time buy (LTB)"	Device will be discontinued and last time buy period and delivery is in effect
"Not recommended for new designs"	Device is still in production to support existing designs and production
"Obsolete"	Production has been discontinued

Datasheet status key:

"Draft version"	This term denotes a very early datasheet version and contains highly provisional information, which may change in any manner without notice.
"Provisional version"	This term denotes a pre-release datasheet. It provides a clear indication of anticipated performance. However, changes to the test conditions and specifications may occur, at any time and without notice.
"Issue"	This term denotes an issued datasheet containing finalized specifications. However, changes to specifications may occur, at any time and without notice.

Diodes Zetex sales offices

Europe	Americas	Asia Pacific	Corporate Headquarters
Zetex GmbH Kustermann-park Balanstraße 59 D-81541 München Germany Telefon: (49) 89 45 49 49 0 Fax: (49) 89 45 49 49 49 europe.sales@zetex.com	Zetex Inc 700 Veterans Memorial Highway Hauppauge, NY 11788 USA Telephone: (1) 631 360 2222 Fax: (1) 631 360 8222 usa.sales@zetex.com	Diodes Zetex (Asia) Ltd 3701-04 Metroplaza Tower 1 Hing Fong Road, Kwai Fong Hong Kong Telephone: (852) 26100 611 Fax: (852) 24250 494 asia.sales@zetex.com	Diodes Incorporated 15660 N. Dallas Parkway Suite 850, Dallas TX75248, USA Telephone (1) 972 385 2810 www.diodes.com

© 2008 Published by Diodes Incorporated